

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/721,751	SHIINA ET AL.	
	Examiner	Art Unit	
	Marc A. Scharich	3611	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
<u>See Attached</u>		2/21/2007	MAS